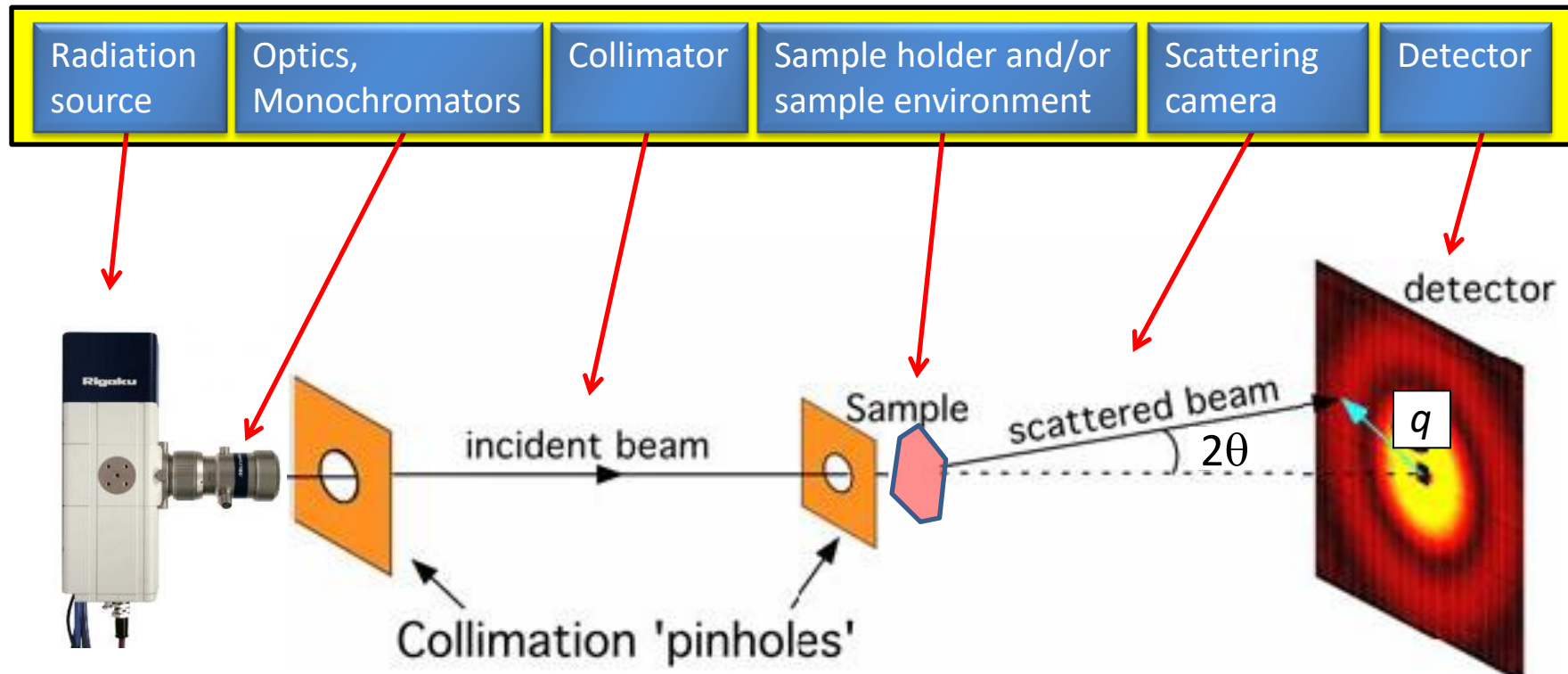


Laboratory Small-Angle X-ray scattering Instrument: State-of-the-Art and Applications

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By no means a complete outline!



$$q = 4\pi \sin \theta / \lambda$$

Diamond Light Source (X-rays)



ISIS Spallation Source (neutrons)



Laboratory SAXS
Xenocs Xeuss + Excillum MetalJet
Bruker Nanostar

Detector

Collimating slits

Monochromator

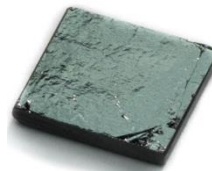
X-ray source



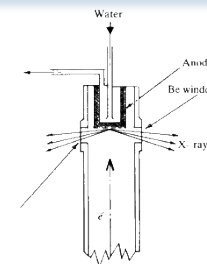
X-ray films



Lead pinholes

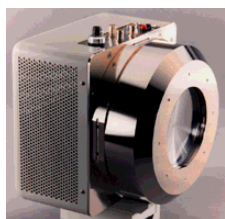


Graphite crystal



Solid anode

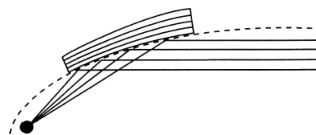
1990s



Multi-wire gas detector



Lead pinholes



Gobel mirror



Solid (rotating) anode

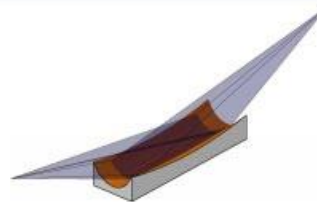
2000s



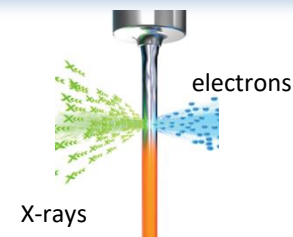
Pixel detector



Scatterless slits comprised of motorized single crystal blades



Montel optics or 3D multi-layered mirror

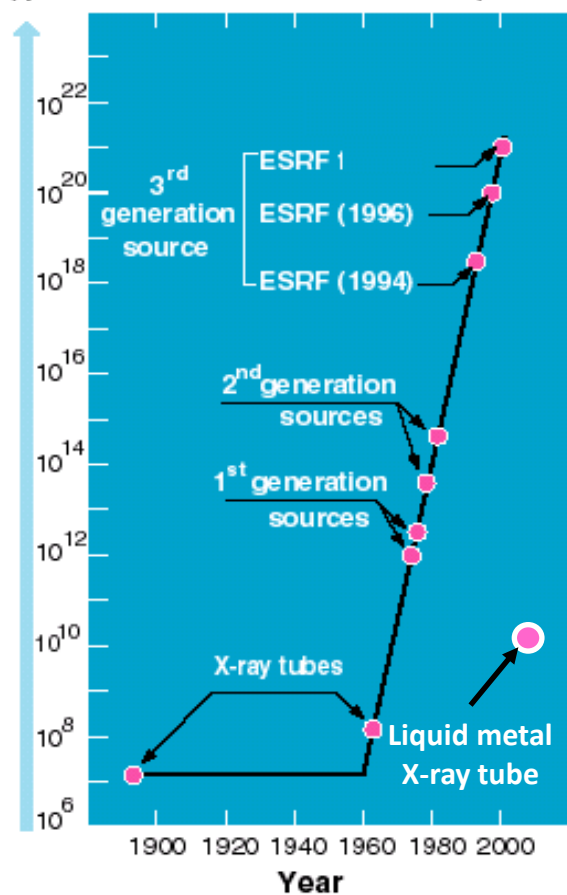


Liquid metal anode

Current
state of
play

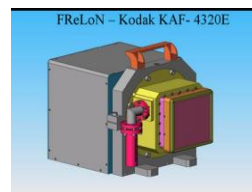
X-ray source

Brilliance of the X-ray beams
(photons / s / mm² / mrad² / 0.1% BW)



Detector

CCD



Multi-wire detector



Pixel detector



Characteristics	FReLon	RAPID 2	Pilatus
Dynamic range, bits	16	16	20
Counting rate limit, photons/mm ² /s	low	~ 10 ⁶	~ 10 ⁷
Pixel size	>6x6 μm	~100x100 μm	>75x75 μm
Framing rate, Hz	< 15	10 ⁶	100

Outline of our laboratory SAXS instrument

X-ray source, Liquid Gallium MetalJet



X-ray mirror



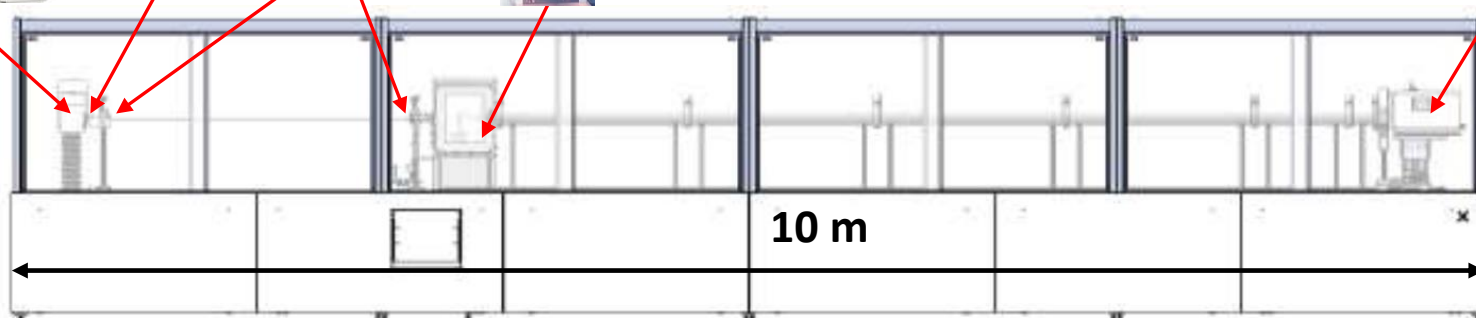
Scatterless slits



WAXS detector, Pilatus 100K



SAXS detector, Pilatus 1M



MetalJet Liquid Gallium X-ray source

3D multilayered X-ray mirror

Two sets of motorized scatterless slits

Two Dectris detectors: Pilatus1M (SAXS) and Pilatus 100K (WAXS)

Sample-to-detector distance 6.4 m

Resolution: 0.001 \AA^{-1} ($\sim 6000 \text{ \AA}$)

Simultaneous SAXS/WAXS

GiSAXS/GiWAXS

X-ray reflectometry



MetalJet Liquid Gallium X-ray source
3D multilayered X-ray mirror
Two sets of motorized scatterless slits
Two Dectris detectors: Pilatus1M (SAXS) and Pilatus 100K (WAXS)
Sample-to-detector distance 6.4 m
Resolution: 0.001 \AA^{-1} ($\sim 6000 \text{ \AA}$)
Simultaneous SAXS/WAXS
GiSAXS/GiWAXS
X-ray reflectometry

Thus, modern laboratory X-ray scattering instrument can be used pretty much for all standard X-ray scattering techniques

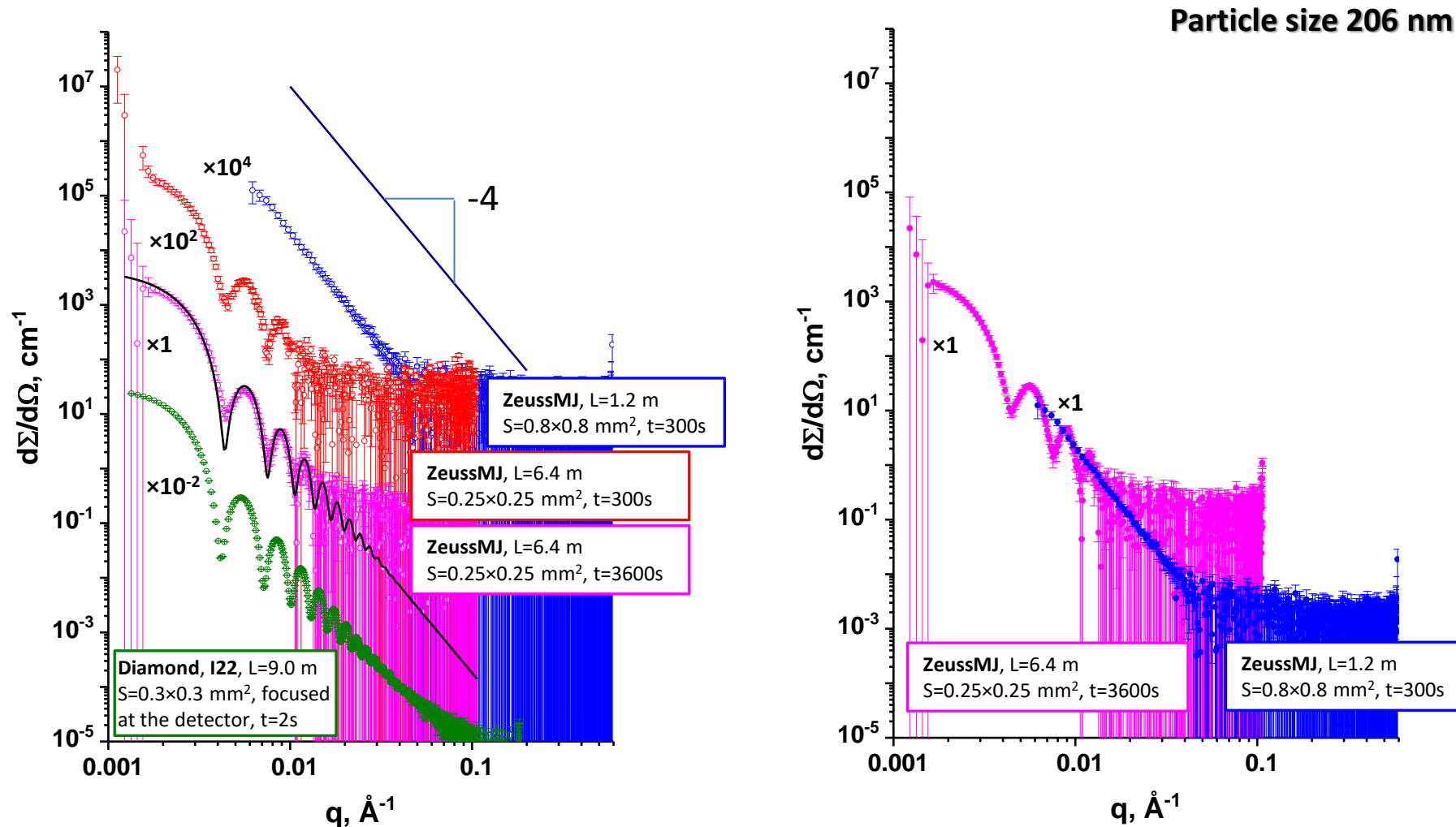
SAXS

WAXS

GiSAXS

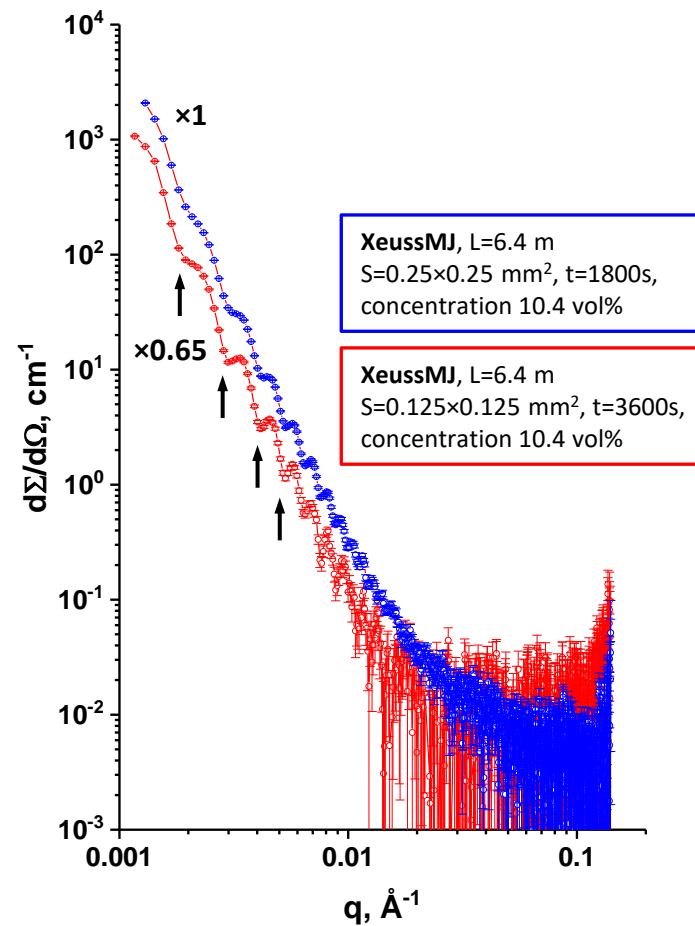
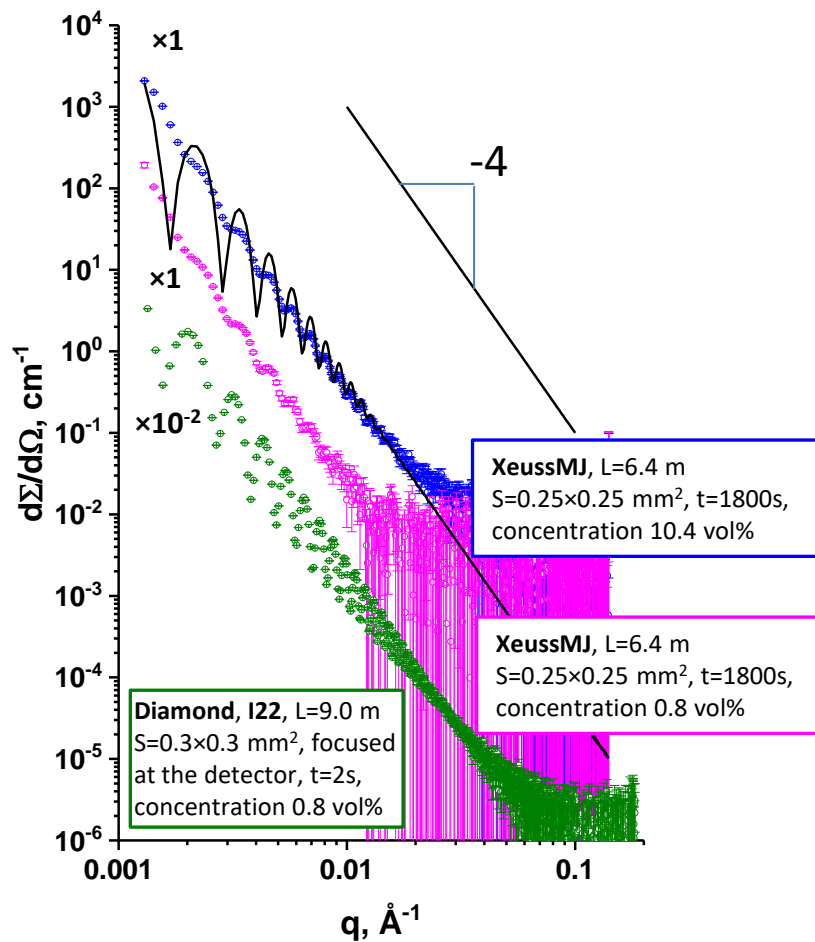
GiWAXS

X-ray reflectometry



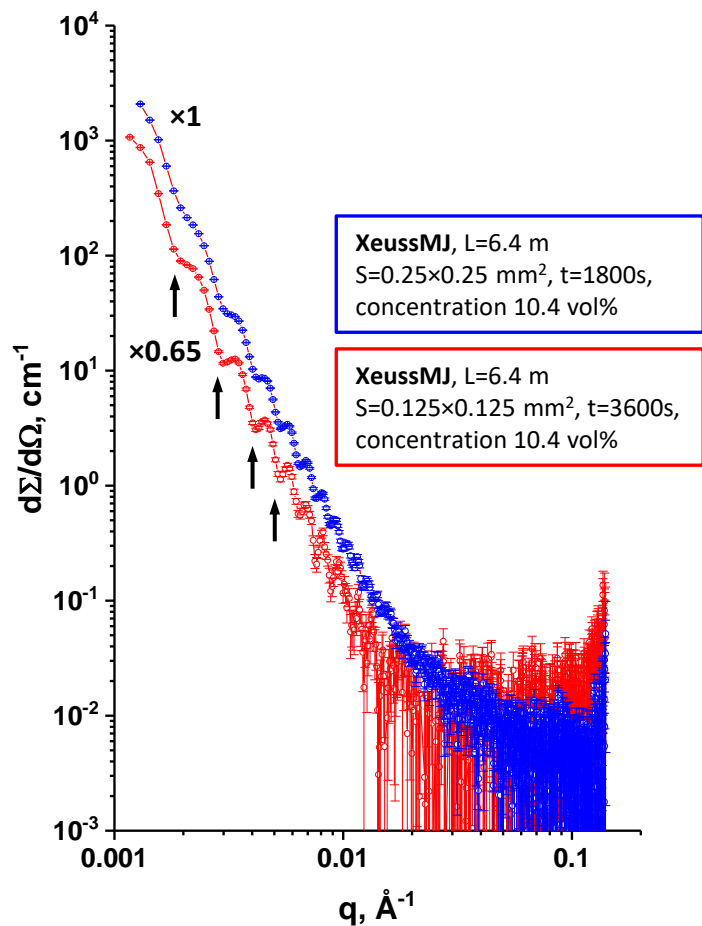
1wt% (0.8 vol%) P2VP (C₇H₇N)_n spherical particles in water, R = 1030 Å, σ_R = 35 Å, Δρ² = 1.335×10²⁰ cm⁻⁴

Particle size 540 nm



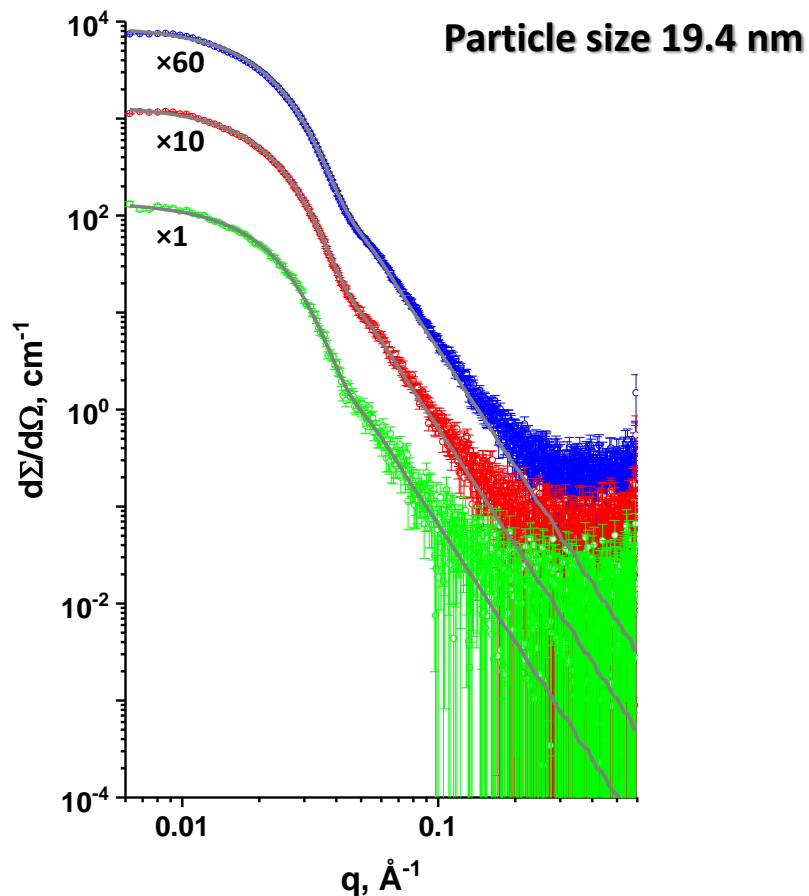
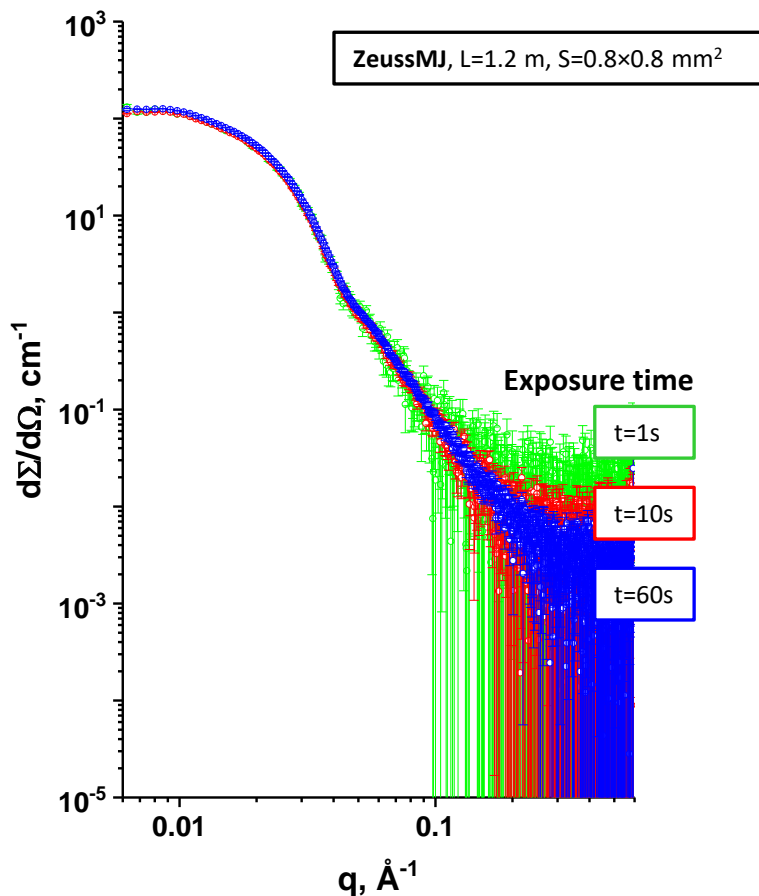
P2VP (C₇H₇N)_n spherical particles in water, R = 2700 Å, σ_R = 35 Å, Δρ² = 1.335×10²⁰ cm⁻⁴

Particle size 540 nm



Thus, in terms of spatial resolution a modern laboratory X-ray scattering instrument can be used for analysing structural formations/morphologies/objects as large as **0.5 micron** reaching the lower limit of resolution of standard optical microscopes.

P2VP (C₇H₇N)_n spherical particles in water, R = 2700 Å, σ_R = 35 Å, Δρ² = 1.335×10²⁰ cm⁻⁴



1wt% (0.49 vol%) Silica spherical particles in water,

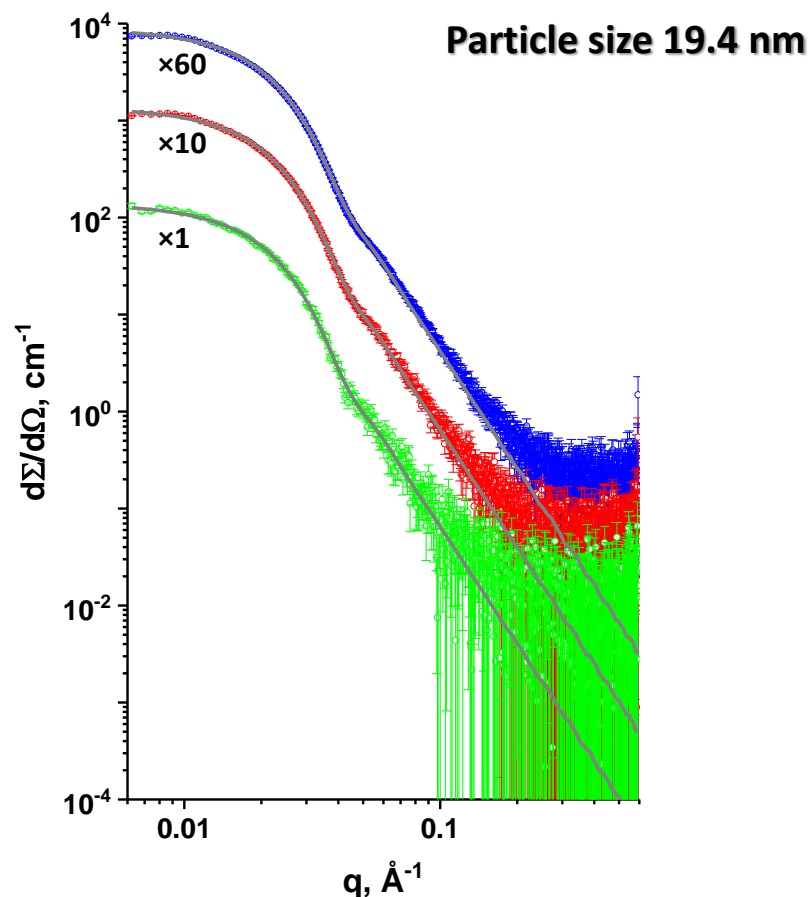
$R = 97$ Å, $\sigma_R = 22$ Å, $\Delta\rho^2 = 65.9 \times 10^{20}$ cm⁻⁴

Exp. conditions	Vol%	R , Å	σ_R , Å
As prepared	0.49	-	-
SAXS, 1s exposure	0.47	97.6	21.2
SAXS, 10 exposure	0.47	97.2	21.6
SAXS, 60s exposure	0.50	97.2	21.9

Thus, in terms of time resolution a modern laboratory X-ray scattering instrument can be used for analysing structural formations/morphologies/objects at a time resolution as low as **one second** enabling to perform standard (not highly demanding) time-resolved measurements of structural formations/transformations.

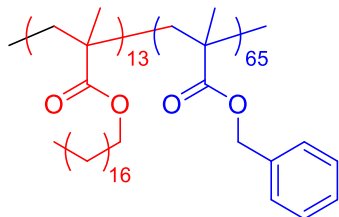
1wt% (0.49 vol%) Silica spherical particles in water,

$R = 97 \text{ \AA}$, $\sigma_R = 22 \text{ \AA}$, $\Delta\rho^2 = 65.9 \times 10^{20} \text{ cm}^{-4}$



Exp. conditions	Vol%	R, Å	σ_R , Å
As prepared	0.49	-	-
SAXS, 1s exposure	0.47	97.6	21.2
SAXS, 10 exposure	0.47	97.2	21.6
SAXS, 60s exposure	0.50	97.2	21.9

SAXS of 1.0% w/w PSMA₁₃-PBzMA₆₅ diblock copolymer worm-like micelles in mineral oil

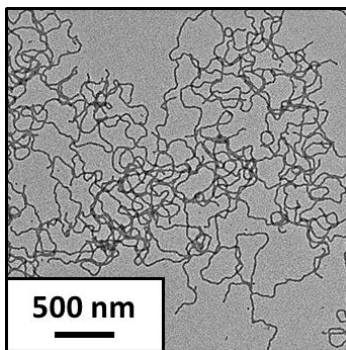


Synchrotron source

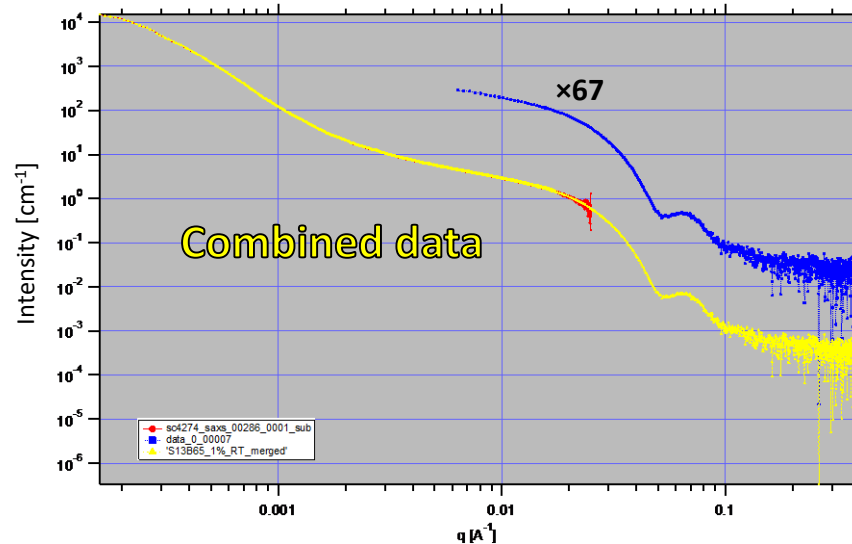
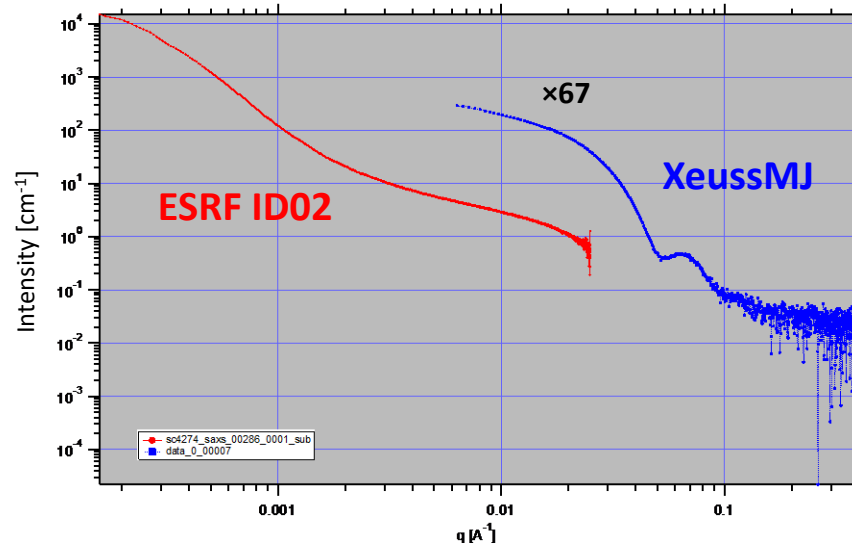
ESRF ID02, L=31 m, 300 ms acquisition

Laboratory SAXS instrument

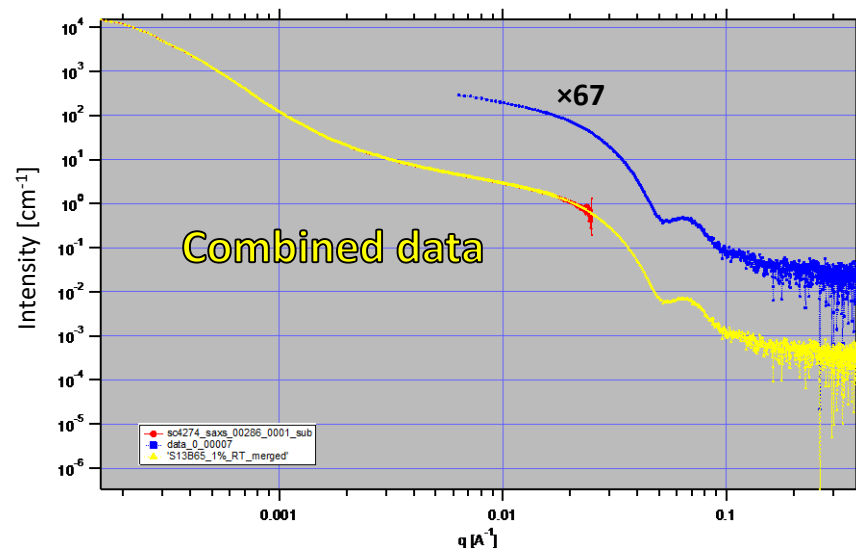
XeussMJ, L=1.9 m, 600 s acquisition



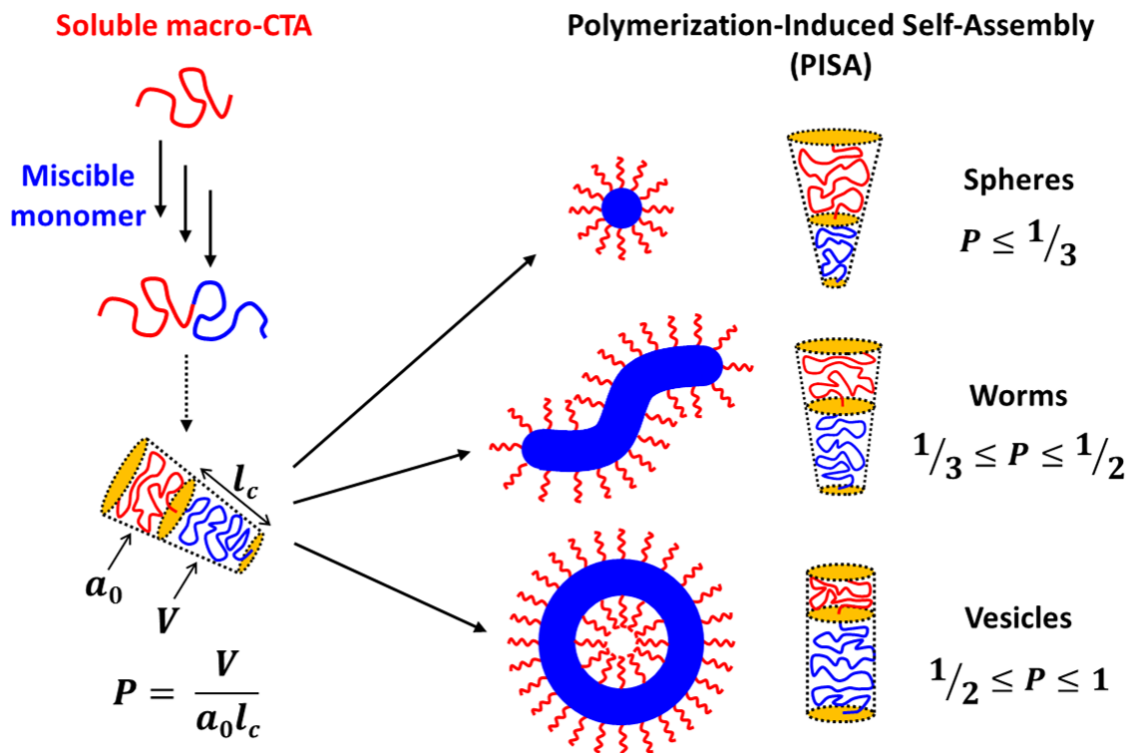
Branched worm-like micelles at RT



Thus, a modern laboratory X-ray scattering instrument can be successfully **used for analysing structural formations/morphologies/objects in a combination with synchrotron** measurements which can save expensive synchrotron time for advanced measurements and improve quality of collected data.



Block Copolymer Self-Assembly via Polymerization-Induced Self-Assembly (PISA)

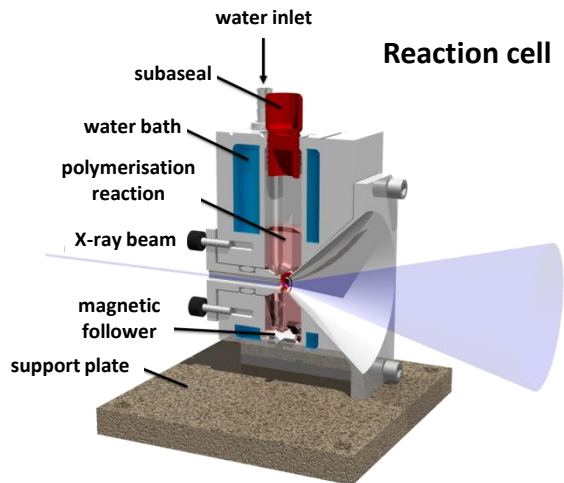
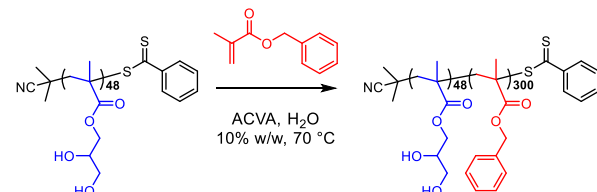


In practice, particle morphology also depends on copolymer concentration

N. J. Warren & S. P. Armes, *J. Am. Chem. Soc.*, **2014**, 136, 10174
M. J. Derry, L. A. Fielding & S. P. Armes, *Prog. Polym. Sci.*, **2016**, 12, 1
S. L. Canning, G. N. Smith & S. P. Armes, *Macromolecules*, **2016**, 49, 1985

RAFT polymerization and PISA of PGMA₄₈-PBzMA₃₀₀ in water

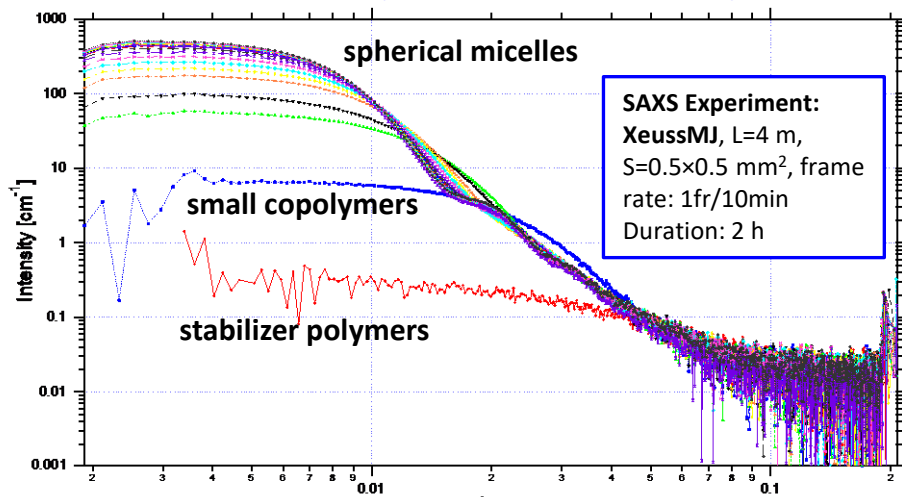
Reaction conditions: 10% w/w, reaction temperature 70 °C



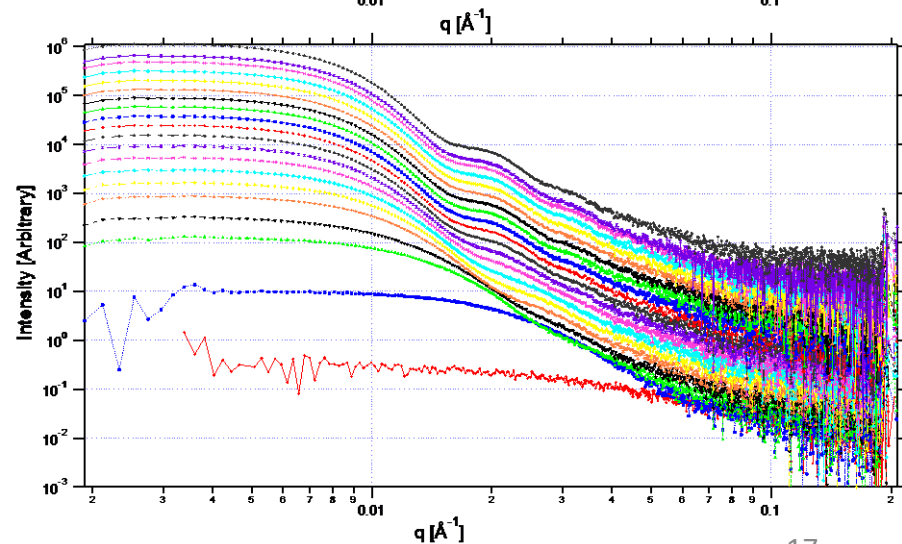
Reaction cell

Details of the synthesis:
V. J. Cunningham et al, *Macromolecules*, **2014**, *47*, 5613–5623

Details of SAXS analysis:
M. J. Derry et al, *Chemical Science*, **2016**, *7*, 5078

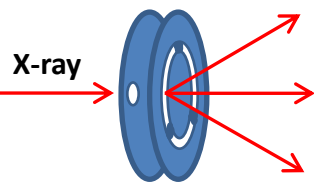


Reaction cell mounted on Xeuss

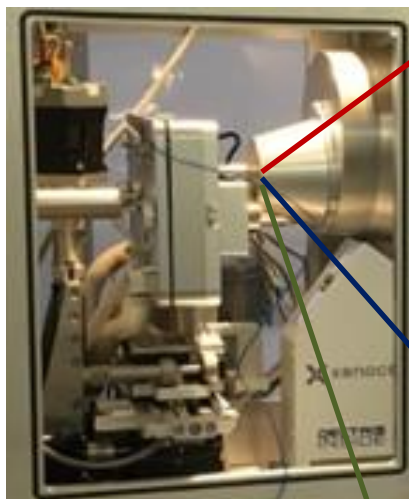
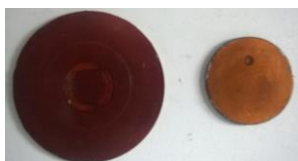


Linkam shear cell CSS-450 mounted on XeussMJ instrument

Parallel plate geometry



modified shearing disks
two kapton windows
transparent for X-rays
(70 microns each)



Shear-alignment of PS-PI block-copolymer spherical micelle dispersion

- 5 wt% dispersion of PS-PI copolymer micelles
- Sample-to-detector distance 2.5 m
- Exposure time 300 s
- Oscillatory shear

Flow-induced crystallization of semi-crystalline polymer (HDPE)

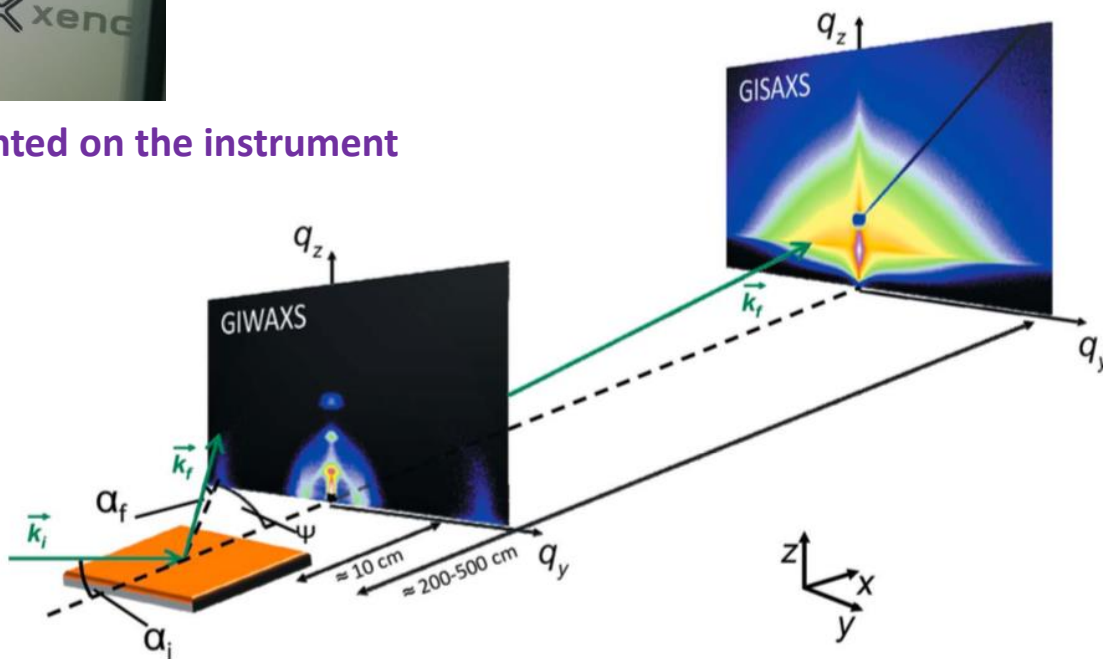
- HDPE melt
- Sample-to-detector distance 3.8 m
- Exposure time 60 s
- Shear pulse

Transformation of block copolymer self-assembled morphologies under shear and temperature

- 15 wt% aqueous dispersion of thermo-responsive block-copolymers
- Sample-to-detector distance 3.8 m
- Exposure time 60 s
- Continuous shear



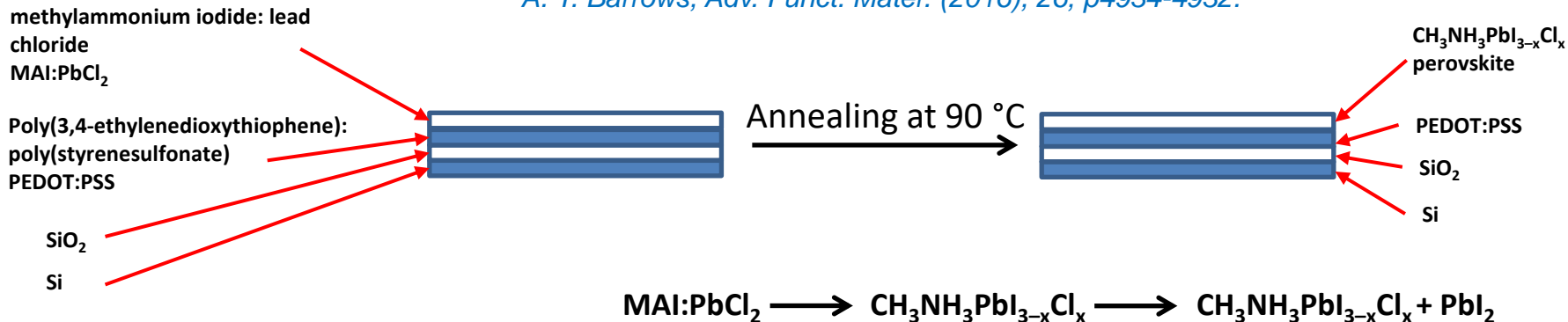
Standard GISAXS/GIWAXS stage mounted on the instrument



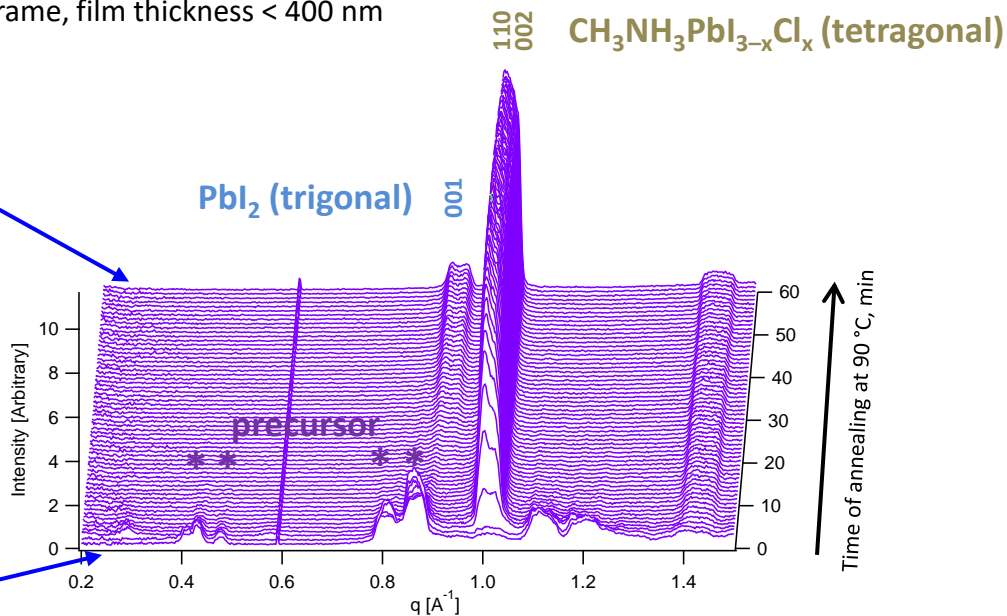
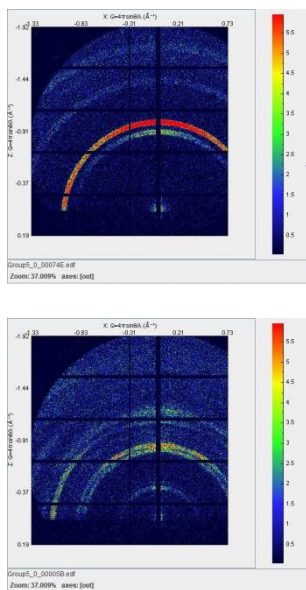
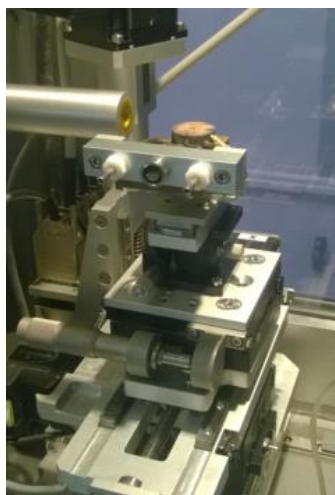
taken from A. Hexemer & P. Muller-Buschbaum, *IUCrJ* (2015), 2, p106–125

CH₃NH₃PbI_{3-x}Cl_x Perovskite photovoltaic device manufacturing

A. T. Barrows, *Adv. Funct. Mater.* (2016), 26, p4934-4932.

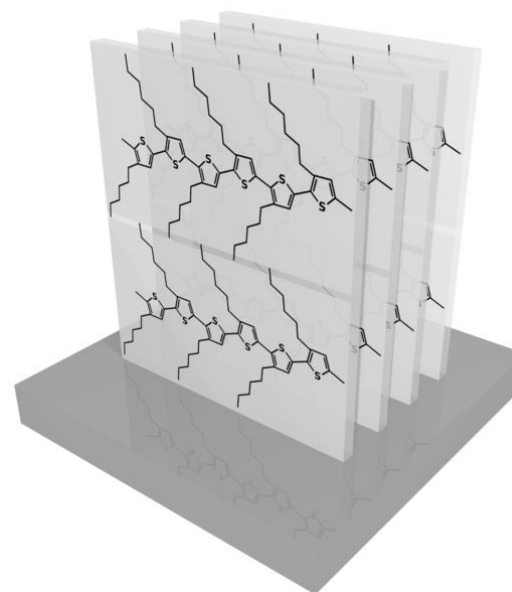
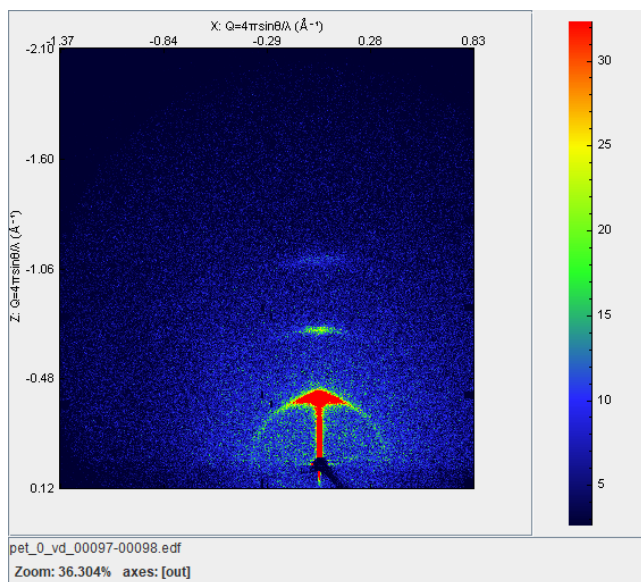


Conditions for the data collection: exposure time 1 min/frame, film thickness < 400 nm



Organic solar cells

P3HT – conjugated polymer – edge on orientation



Conditions for the data collection: exposure time 10 min; film thickness < 200 nm
two positions of the detector were used in order to erase the detector dead stripes from 2D scattering patterns

Laboratory X-ray scattering instruments and, in particular, **SAXS instruments** have undergone significant development for the last decade and become **powerful devices available for researchers with 24/7 access all year round.**

Due to high X-ray flux and improved collimation it is possible to reach both **size resolution** of the scattering objects **up to 0.5 microns** and **time resolution of a few seconds.**

The recent developments of X-ray sources, detectors and X-ray optics opened up **new opportunities for in-house experiments on structural characterisation of nano-scaled morphologies** formed by inorganic and organic materials especially biomaterials, gels, colloids, nanoparticles and polymers.

Design of the modern X-ray scattering instruments enables **simultaneous SAXS/WAXS measurements in-situ using different sample environments** such as heating stages, shear cells and reactor cells.

Sheffield University users of the SMALL

From Physics Department

Andrew Parnell
Benjamin Freestone
Mark Geoghegan
Richard Jones
David Lidzey
Fabio Pontecchiani

From Chemistry Department

Thomas Neal
Matthew Derry
Cate O'Brien
Steve Armes
Sarah Bayard
Andrew Campbell
Thomas Franklin
Fiona Hutton
Anthony Ryan